

Notic of Referenc s Cit d	Application/Control No. 10/670,697	Applicant(s)/Patent Under Reexamination SIMON ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,476,657	11-2002	Kuhne, Sebastian	327/291
	C	US-5,933,032	08-1999	Shah et al.	327/34
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	E	US-5,546,034	08-1996	Han, Tae H.	327/174
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